XJP-146JB Series



This equipment can be used in observation, analysis and research of Metallurgy, Mineral, Crystal, Micro-electronics and it is the first choice for the factories, universities, research institutions and electronic industry. It is adopted 2 kinds of illumination of reflection and transmission and also equipped with Epi-illumination Polarization devices. Under the reflected light, it can proceed Bright field and Polarizing observation. And it can also proceed Bright field observation under transmitted illumination. Stable, high-quality optical systems meet your requirement of high image quality, square-built body represents more rigid, the T-shaped design gives you a more stable base. Humanized configuration design and convenient operation, Let you release from the pressure of heavy work. Let you devote experiment with entire energy.

Superification			Model		
Specification		XJP-146JB	XJP-146JBT		
Viewing Head Eyepiece	Compensation Free Binocular Head Inclined at 30°		•		
	(55mm-75mm)				
	Compensation Free Trinocular Head Inclined at 30° (55mm-75mm)			•	
	WF10×/22mm		•	•	
	WF10×/20mm,crosshair with reticule 0.1mm		•	•	
Nosepiece	Quadruple nosepiece		•	•	
Objective	Infinity Plan metallurgical	4×/0.1W.D.29.4mm	•	•	
		10×/0.25W.D.16mm	•	•	
		20×/0.4W.D.10.6mm	•	•	
	objective	40×/0.6W.D.5.4mm	•	•	
	Double layer mechanic				
Stage	Stage Size: 180mm×150mm		•	•	
	Moving Range:75mm×50mm				
Focusing	Coaxial coarse & fine focusing adjustment With rack and Focusing pinion mechanism. Fine focusing scale value 0.002mm		•	•	
Condenser	N.A.1.25 Abbe Condenser with iris diaphragm & filter		•	•	
Light Source	Epi-Kohler illumination with aperture iris diaphragm and		•	•	
	Transmission illumination 12V/30W.AC85V230V Adjustable Brightness		•	•	
Polarizing Device	Analyzer rotatable360,°Polarizer & Analyzer can be moved in/out of the optical path		•	•	
Filter	Flashboard type filters(green ,blue neutral)		•	•	
Checking Tool	0.01mm Micrometer		•	•	
Optional Accessory	Two-dimensional measure software				
	Professional metallurgical image analysis software				
	micrometer eyepiece				
	1.3Mega, 2.0 Mega, 3.0 Mega, 5.0 Megapixels CMOS Digital camera eyepiece				
	Photography attachment and CCD Adapter $0.5\times$, $0.57\times$, $0.75\times$				

Infinity Plan metallurgical objective: 50×/0.55W.D.5.1mm, 80×/0.75W.D.4mm,
100
×/0.8W.D.3mm
Planishing tool
CCD Camera, colour 1/3" High resolution 520 TV lines